

<b>Notice of References Cited</b>	Application/Control No. 10/644,290	Applicant(s)/Patent Under Reexamination KANG ET AL.	
	Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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